

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT & TRADEMARK OFFICE

SHEET 1 OF 1
(REV. 7-80)**LIST OF REFERENCES CITED BY APPLICANT**

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APPLICANT: Andrew Patrick Baird FILING DATE: May 17, 2000
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U.S. PATENT DOCUMENTS

| <u>*EXAMINER</u> <u>INITIALS</u> | <u>DOCUMENT</u> <u>NUMBER</u> | <u>DATE</u> | <u>NAME</u> | <u>CLASS</u> | <u>SUBCLASS</u> | <u>FILING DATE</u> |
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FOREIGN PATENT DOCUMENTS

| <u>*EXAMINER</u> <u>INITIALS</u> | <u>DOCUMENT</u> <u>NUMBER</u> | <u>DATE</u> | <u>COUNTRY</u> | <u>CLASS</u> | <u>SUBCLASS</u> | <u>TRANSLATION</u> <u>YES</u> <u>NO</u> |
|-------------------------------------|----------------------------------|-------------|----------------|--------------|-----------------|--|
| 1. <i>B</i> | W096 28857 | 9/19/96 | PCT | | | |
| 2. <i>R</i> | EP0834953 | 4/8/98 | EP | | | |

OTHER REFERENCES**(INCLUDING AUTHOR, TITLE DATE, PERTINENT PAGES, ETC.)***EXAMINER
INITIALS

3. *B* Patent Abstracts of Japan - Vol. 14, No. 175, April 6, 1990 (NEC Corp.)
4. *A* Patent Abstracts of Japan - Vol. 1996, No. 4, April 30, 1996 (Fujitsu General Ltd.)

EXAMINER: BENNY T. LEEDATE CONSIDERED: 20 March 2003

PRIMARY EXAMINER

ART UNIT 2817

*EXAMINER:

Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.